Notice of References Cited Application/Control No. 10/040,632 Examiner Afsar M. Qureshi Applicant(s)/Patent Under Reexamination KANG ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2001/0002906	06-2001	Rune, Johan	370/345
	В	US-			
	С	US-			
	D.	US-	•		
	Ε	US-			
	F	US-			
	G	US-	,		
	Н	US-			
	I	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	10-2001-0004954	01-2001	Kr	Jang et al. (Kta. ***iron	
	0					
	Р					
	Q					
	R					
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	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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